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⁸C. Wieman and T. W. Hänsch, Phys. Rev. Lett. 36, 1170 (1976).
 ⁹A. Javan, J. Opt. Soc. Am., 67, 1413 (1977).

¹⁰W. R. C. Rowley, K. C. Shotton, and P. T. Woods, in *Laser Spectroscopy III*, edited by J. L. Hall and J. L. Carlsten, (Springer-Verlag, New York, 1977), p. 425.

Consequences of light reflection at the interface between two transparent media such that the angle of refraction is 45°

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The reflection of light at the interface between two transparent, homogeneous and optically isotropic media such that the angle of refraction is 45° has the following interesting consequences: (i) the interface reflectivity for the parallel (p) polarization is the square of that for the perpendicular (s) polarization; (ii) the angular deviation of the propagation direction upon refraction is equal to the polarization (or ellipsometric) angle ψ ; and (iii) the complex reflection coefficient for the p polarization is stationary, in both magnitude and phase, with respect to small charges of the (refractive and/or absorptive) optical properties of either one or both media. Furthermore, it follows from (iii) that: (iv) reflectivity of the p polarization, considered as a function of the ratio of refractive indices of the two media, is at a maximum; and (v) changes of the absolute magnitude and absolute phase of the reflection coefficient for the s polarization, caused by small perturbations of the optical properties, can be measured directly by ellipsometry.

When considering the reflection of light, or any other electromagnetic radiation, at the interface between two transparent, homogeneous, and isotropic media, certain angles of incidence are distinguished for their special significance. The most well known are the Brewster angle and the critical angle. At the Brewster angle light polarized parallel to the plane of incidence is completely extinguished upon reflection, and the associated reflection phase shift experiences a jump of π as the angle of incidence is swept past the Brewster angle. The critical angle marks the onset of total internal reflection and exists only when light is incident on the interface from the medium of higher refractive index. To these special angles we may add 0°, 45°, and 90° which correspond to normal incidence, symmetrical incidence, and grazing incidence, respectively.

Incidence at 45° has the little known distinction of making the interface reflectivity for the p polarization equal to the square of that for the s polarization. We have known that incidence at 45° has other interesting consequences (see the following).

In this Letter we introduce another angle of incidence of special significance, namely the angle of incidence that makes the angle of refraction equal to 45°. At this angle we will prove that (i) the reflectivity for the p polarization is the square of the reflectivity for the s polarization; and (ii) the angular deviation of the propagation direction upon refraction is equal to the polarization or ellipsometric angle ψ . These two properties also apply when the angle of incidence is 45°. In addition, at this new angle, the complex Fresnel reflection coefficient for the p polarization is stationary, in both magnitude and phase, with respect to small changes of the optical properties of either one or both media. Because no similar effect is encountered with the s polarization, small changes

of the complex reflection coefficient of s polarized light can be measured directly by ellipsometry.⁴

Consider the reflection of light at an angle of incidence ϕ by the interface between two homogeneous and isotropic media with refractive indices n and N. The angle of refraction ϕ' is determined by Snell's law:

$$n\sin\phi = N\sin\phi'. \tag{1}$$

The Fresnel reflection coefficients for the p and s polarizations (with linear electric field vibrations parallel and perpendicular to the plane of incidence, respectively) can be expressed in terms of ϕ and ϕ' only as⁵

$$r_p = \tan(\phi - \phi')/\tan(\phi + \phi'), \tag{2}$$

$$r_s = -\sin(\phi - \phi')/\sin(\phi + \phi'). \tag{3}$$

Alternatively, r_p and r_s can be written as functions of ϕ and the refractive index ratio

$$\nu = N/n,\tag{4}$$

by eliminating ϕ' from Eqs. (2) and (3) using Eq. (1):

$$r_p = \frac{\nu^2 \cos\phi - (\nu^2 - \sin^2\phi)^{1/2}}{\nu^2 \cos\phi + (\nu^2 - \sin^2\phi)^{1/2}}$$
 (5)

$$r_s = \frac{\cos\phi - (\nu^2 - \sin^2\phi)^{1/2}}{\cos\phi + (\nu^2 - \sin^2\phi)^{1/2}}$$
(6)

From Eq. (1), the angle of incidence ϕ that makes the angle of refraction $\phi'=45^\circ$ is given by

$$\sin\phi = \nu/\sqrt{2} \,. \tag{7}$$

This angle exists always in internal reflection ($\nu < 1$), and exists in external reflection only if $\nu < \sqrt{2}$. Table I gives this angle for two common interfaces.

TABLE I. Some values of the angle of incidence ϕ for light refraction at 45°.*

Interface	air-water	water-air	air–glass	glass-air
ν	1.33	1/1.33	1.5	1/1.5
$\nu \geq \sqrt{2}$?	$<\sqrt{2}$	$<\sqrt{2}$	$>\sqrt{2}$	$<\sqrt{2}$
ϕ (degrees)	70.127	32.118	nonexistent	28.126

^{*} We assume that the wavelength of light is in the visible spectrum.

When the angle of refraction ϕ' = 45°, Eqs. (2) and (3) become

$$r_p = -\tan^2(\phi - 45^\circ),$$
 (8)

$$r_s = -\tan(\phi - 45^\circ),\tag{9}$$

as can be proved by the application of some trigonometry.⁶ From Eqs. (8) and (9) it is evident that

$$r_p = -r_s^2, (10)$$

and

$$R_p = R_s^2, (11)$$

so that the reflectance ($R = |r|^2$) for the p polarization is the square of the reflectance for the s polarization. Equation (11) is satisfied also when the angle of incidence $\phi = 45^{\circ}$.¹⁻³ Equations (8) and (9) show that, when the angle of refraction is 45° , the reflection phase shift for the p polarization is π , while that for the s polarization is either π (external incidence, $\phi > 45^{\circ}$) or 0 (internal incidence $\phi < 45^{\circ}$).

The ratio of r_p and r_s is given by

$$\rho = r_p/r_s$$

$$= \tan \nu e^{j\Delta}$$

$$= \tan(\phi - 45^\circ), \qquad (12)$$

as can be seen from Eqs. (7) and (8), and

$$\psi = |\phi - 45^{\circ}|.$$
 (13)

Equation (13) tells us that the angular beam deviation upon refraction when $\phi'=45^{\circ}$ is equal to the polarization angle ψ , Fig. 1. We have found that a similar relation applies when the angle of incidence is 45° .³ This relation between propagation directions and polarization directions is probably one of the simplest possible links between geometrical optics and physical optics.

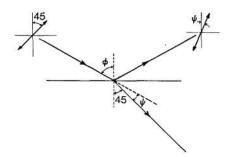


FIG. 1. When light is incident on the interface between two transparent media such that the angle of refraction is 45° , the angular deviation of the propagation direction caused by refraction equals the polarization (ellipsometric) angle $\psi.$

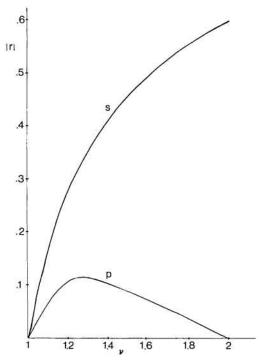


FIG. 2. The magnitude |r| of Fresnel's reflection coefficients for the parallel (p) and perpendicular (s) polarizations as functions of the refractive index ratio ν between $\nu=1$ and $\nu=2$. We assume light reflection at the interface between two transparent media at the fixed angle of incidence $\phi=\tan^{-1}2=63.435^{\circ}$. Note that $|r_p|$ goes through a peak when $\nu=\sqrt{2}$ $\sin\phi=1.265$ (i.e. when the light is refracted at 45°), whereas $|r_s|$ increases monotonically. r_p and r_s are both real and negative.

When the angle of incidence is fixed, and the refractive index ratio ν is varied, the reflection coefficient for the p polarization as a function of ν , r_p (ν), must go through a peak between $\nu=1$ and $\nu=\tan\phi$, because r_p (1) = r_p ($\tan\phi$) = 0. To determine the position of the peak (i.e., the value of ν at which it occurs), we find the derivative of r_p with respect to ν and equate it to zero. From Eq. (5) we have

$$\frac{\partial r_p}{\partial \nu} = \frac{2\nu \cos\phi \ (\nu^2 - 2\sin^2\phi)}{(\nu^2 - \sin^2\phi)^{1/2} \ [\nu^2 \cos\phi + (\nu^2 - \sin^2\phi)^{1/2}]^2}, \quad (14)$$

which is equal to zero when $\nu = \sqrt{2} \sin \phi$, i.e., when the angle of refraction is 45° [see Eq. (7)]. The corresponding derivative of r_s with respect to ν ,

$$\frac{\partial r_s}{\partial \nu} = \frac{-2\nu \cos\phi}{(\nu^2 - \sin^2\phi)^{1/2} \left[\cos\phi + (\nu^2 - \sin^2\phi)^{1/2}\right]^2},$$
 (15)

does not vanish for any value of ν in the range⁸ $0 < \nu < \infty$.

As an illustration, Fig. 2 shows $|r_p|$ and $|r_s|$ vs ν between $\nu=1$ and $\nu=2$, when the angle of incidence is fixed at $\phi=\tan^{-1}2=63.435^{\circ}$. Notice that $|r_p|$ goes through a peak at $\nu=\sqrt{2}$ sin63.435° = 1.265, as expected, while $|r_s|$ increases monotonically.

The vanishing of $\partial r_p/\partial \nu$ when the angle of refraction is 45° means that r_p is stationary in both magnitude and phase with respect to small variations of the optical properties of one or both media. This is significant in modulation spectroscopy9 where small changes of the optical properties are induced by a modulating field such as temperature, stress, electric or magnetic field. We have found above that modulation of the

optical properties does not show up in reflection under the following conditions: (i) the media are transparent, (ii) the incident light is p polarized, and (iii) the angle of refraction is 45°.

The reflection coefficient for the s polarization does change when ν is varied in the neighborhood of $\nu = \sqrt{2} \sin \phi$, because $\partial r_s/\partial \nu \neq 0$. The changes of the absolute magnitude and phase of r_s can be measured directly by ellipsometry. In this case small changes of r_s show directly as small changes of the ellipsometric ratio of reflection coefficients $\rho = r_p/r_s$. Because r_p is stationary, we have

$$\frac{\delta\rho}{\rho} = -\frac{\delta r_s}{r_s} = -\frac{1}{r_s} \frac{\partial r_s}{\partial \nu} \, \delta\nu. \tag{16}$$

If we substitute $\nu = \sqrt{2} \sin \phi$ in Eqs. (6) and (15), we find

$$-\frac{1}{r_s}\frac{\partial r_s}{\partial \nu} = \frac{2\sqrt{2}\cos\phi}{\cos 2\phi},\tag{17}$$

or

$$-\frac{1}{r_s}\frac{\partial r_s}{\partial \nu} = 2\sqrt{2} (1 - \frac{1}{2}\nu^2)^{1/2}/(1 - \nu^2). \tag{18}$$

If we take the differential of $\rho = \tan \psi e^{j\Delta}$, we get

$$\delta \rho, \rho = 2\delta \psi / \sin 2\psi + j\delta \Delta.$$
 (19)

In general, $\delta \nu$ can be written as

$$\delta \nu = \delta n - j \delta k, \tag{20}$$

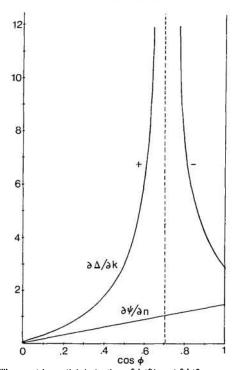


FIG. 3. Ellipsometric partial derivatives $\partial \Delta/\partial k$ and $\partial \psi/\partial n$ vs $\cos \phi$, where ϕ is the angle of incidence that makes the angle of refraction equal to 45°. The + and - signs indicate positive and negative values of $\partial \Delta / \partial k$.

where δn and δk are the changes of the relative refractive index and relative extinction coefficient, respectively. If we substitute Eqs. (17), (19), and (20) into Eq. (16), and use Eq. (13), we obtain

$$\delta \psi = (\sqrt{2} \cos \phi) \delta n,$$

$$\delta \Delta = (-2\sqrt{2} \cos \phi/\cos 2\phi) \delta k,$$
 (21)

and conversely.

$$\delta n = (1/\sqrt{2}\cos\phi)\delta\psi,$$

$$\delta k = (-\cos 2\phi/2\sqrt{2}\cos\phi)\delta\Delta.$$
 (22)

Equations (21) give the changes of the ellipsometric (polarization) parameters $\delta\psi$ and $\delta\Delta$ that are caused by a small change $\delta v = \delta n - j\delta k$ of the complex refractive index ratio v. Notice that δn and δk cause $\delta \psi$ and $\delta \Delta$, respectively. Equations (22) show how perturbations $\delta v = \delta n - i \delta k$ of the complex refractive index ratio ν can be easily determined from measurable changes $\delta\psi$ and $\delta\Delta$ of the ellipsometric parameters. Figure 3 shows

$$\frac{\partial \psi}{\partial n} = \frac{\delta \psi}{\delta n} = \sqrt{2} \cos \phi$$

and

$$\frac{\partial \Delta}{\partial k} = \frac{\delta \Delta}{\delta k} = \frac{-2\sqrt{2}\cos\phi}{\cos 2\phi}$$

as functions of $\cos \phi$. Notice that $|\partial \Delta/\partial k| \rightarrow \infty$ as $\phi \rightarrow 45^{\circ}$. which occurs as $\nu \rightarrow 1$, i.e., when the difference between the optical properties of the two media approach zero. 10 For example, when $\cos \phi = 0.7$ (or $\phi = 45.57^{\circ}$), $\partial \Delta / \partial k = 98.995$ radians per unit of k. This means that an induced change of k as small as 1×10^{-6} causes a change of Δ equal to 0.006°, which is measurable by present-day ellipsometers. It should be observed, however, that as $\nu \to 1$ (and $\phi \to 45^{\circ}$), the intensity of the reflected beam $\rightarrow 0$, so that an intense light source has to be used to utilize the large values of $\partial \Delta / \partial k$.

¹S. P. F. Humphreys-Owen, "Comparison of reflection methods for measuring optical constants without polarimetric analysis, and proposal for new methods based on the Brewster angle," Proc. Roy. Soc. Lond. A 77, 949–957 (1961).

²D. W. Berreman, "Simple relation between reflectances of polarized components of a beam when the angle of incidence is 45 degrees," J. Opt. Soc. Am. 56, 1784 (1966).

³R. M. A. Azzam, "On the reflection of light at 45° angle of incidence," Opt. Acta (in press).

⁴For refraction at 45° we will show that the Fresnel coefficients are interrelated by $r_p = -r_s^2$, so that ellipsometry measures $r_p/r_s = -r_s$. For incidence at 45°, we have $r_p = r_s^2$ and $r_p/r_s = r_s$ (Ref. 3). 5We assume the Nebraska (Muller) conventions. See R. H. Muller,

"Definitions and conventions in ellipsometry," Surf. Sci. 16, 14-33

⁶The proof is analogous to one to be found in Ref. 3.

 $^{7}\nu=\tan\phi$ is Brewster's condition for $r_{p}=0$. $^{8}\partial r_{p}/\partial \nu$ and $\partial r_{s}/\partial \nu$ both vanish in the limiting cases of $\nu=0,\infty$. ⁹See, for example, Vol. 37 of Surface Science: *Proceedings of the First* International Conference on Modulation Spectroscopy, Edited by B. O. Seraphin, (North-Holland, Amsterdam, 1973).

¹⁰This corresponds, for example, to interfaces between the liquid and solid phases of the same substance.